IFW



Docket: 14451.01

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

First Named Inventor:

Bryan J. Root

Appln. No.:

10/607,768

Filed:

June 27, 2003

Shielded Probe Apparatus for Probing

Title:

Semiconductor Wafer

Examiner:

Nguyen, Tung X.

Group Art

Unit:

2829

## AMENDMENT AND RESPONSE UNDER 37 C.F.R. 1.111

Mail Stop Amendments Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 I hereby certify that this document is being sent via First Class U. S. mail addressed to: Mail Stop Amendments, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on this 24<sup>th</sup> day of May, 2005.

Barbara A. Avery

Dear Sir:

In response to the Office Action of February 24, 2005 please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 6 of this paper.